

February 1992 Revised June 2001

74LVQ04 Low Voltage Hex Inverter

General Description

The LVQ04 contains six inverters.

Features

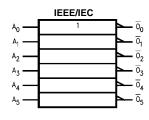
- Ideal for low power/low noise 3.3V applications
- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- \blacksquare Guaranteed incident wave switching into 75 $\!\Omega$

Ordering Code:

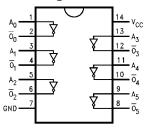
Ordering Number	Package Number	Package Description
74LVQ04SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74LVQ04SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description		
A _n	Inputs		
\overline{O}_n	Outputs		

© 2001 Fairchild Semiconductor Corporation

DS011343

www.fairchildsemi.com

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC}) $$-0.5\rm{V}$ to +7.0V DC Input Diode Current (I $_{\rm{IK}}$)

V_I = -0.5V

 $V_{\rm I} = V_{\rm CC} + 0.5 {\rm V}$ +20 mA DC Input Voltage (V_I) -0.5V to $V_{\rm CC} + 0.5 {\rm V}$

DC Output Diode Current (I_{OK})

 $V_{O} = -0.5V$ -20 mA $V_{O} = V_{CC} + 0.5V$ +20 mA

DC Output Voltage (V_O) -0.5V to $V_{CC} + 0.5V$

DC Output Source

or Sink Current (I_O) $\pm 50 \text{ mA}$

DC V_{CC} or Ground Current

 $(I_{CC} \text{ or } I_{GND})$ ±200 mA

Storage Temperature (T_{STG}) $-65^{\circ}C$ to $+150^{\circ}C$

DC Latch-Up Source or

Sink Current ±100 mA

Recommended Operating Conditions (Note 2)

Minimum Input Edge Rate (ΔV/Δt)

 V_{IN} from 0.8V to 2.0V

V_{CC} @ 3.0V 125 mV/ns

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	v _{cc}	$T_A = +25^{\circ}C$		$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	Units	Conditions	
Syllibol		(V)	Тур	Gua	ranteed Limits	Units	Conditions	
V _{IH}	V _{IH} Minimum High Level		1.5	2.0	2.0	V	V _{OUT} = 0.1V	
	Input Voltage	3.0	1.5	2.0	2.0	v	or V _{CC} – 0.1V	
V _{IL}	Maximum Low Level	3.0	1.5	0.8	0.8	V	V _{OUT} = 0.1V	
	Input Voltage	3.0	1.0	0.0	0.6	V	or V _{CC} – 0.1V	
V _{OH}	Minimum High Level	3.0	2.99	2.9	2.9	V	I _{OUT} = -50 μA	
	Output Voltage	3.0		2.58	2.48	V	$V_{IN} = V_{IL}$ or V_{IH} (Note 3)	
		3.0		2.50	2.40	•	$I_{OH} = -12 \text{ mA}$	
V _{OL}	Maximum Low Level	3.0	0.002	0.1	0.1	V	I _{OUT} = 50 μA	
	Output Voltage	3.0		0.36	0.44	V	$V_{IN} = V_{IL}$ or V_{IH} (Note 3)	
		3.0		0.30	0.44	v	I _{OL} = 12 mA	
I _{IN}	Maximum Input	3.6		±0.1	±1.0	μА	$V_I = V_{CC}$	
	Leakage Current	3.0		±0.1	11.0	μΑ	GND	
I _{OLD}	Minimum Dynamic (Note 4)	3.6			36	mA	V _{OLD} = 0.8V Max (Note 5)	
I _{OHD}	Output Current	3.6			-25	mA	V _{OHD} = 2.0V Min (Note 5)	
I _{CC}	Maximum Quiescent	m Quiescent 3.6 2.0 20.0		20.0	μА	$V_{IN} = V_{CC}$		
	Supply Current	3.0		2.0	20.0	μΑ	or GND	
V _{OLP}	Quiet Output	3.3	0.8	1.1		V	(Note 6)(Note 7)	
	Maximum Dynamic V _{OL}	3.3	0.0	1		•	(Note o)(Note 1)	
V _{OLV}	Quiet Output	3.3	-0.8	-1.1		V	(Note 6)(Note 7)	
	Minimum Dynamic V _{OL}	3.3	-0.6	-1.1		•	(11010 0)(11010 1)	
V _{IHD}	Maximum High Level	3.3	3 1.7	2.0		V	(Note 6)(Note 8)	
	Dynamic Input Voltage			v	(140.0 0)(140.0 0)			
V _{ILD}	Maximum Low Level	3.3	1.6	0.8		V	(Note 6)(Note 8)	
	Dynamic Input Voltage	3.3	1.0	0.6		٧	(14016 0)(14016 0)	

-20 mA

Note 3: All outputs loaded; thresholds on input associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: Incident wave switching on transmission lines with impedances as low as 75Ω for commercial temperature range is guaranteed for 74LVQ.

Note 6: Worst case package.

Note 7: Max number of outputs defined as (n). Data inputs are driven 0V to 3.3V; one output at GND.

Note 8: Max number of Data Inputs (n) switching. (n-1) inputs switching 0V to 3.3V. Input-under-test switching: 3.3V to threshold (V_{ILD}) 0V to threshold (V_{IHD}) f=1 MHz.

AC Electrical Characteristics

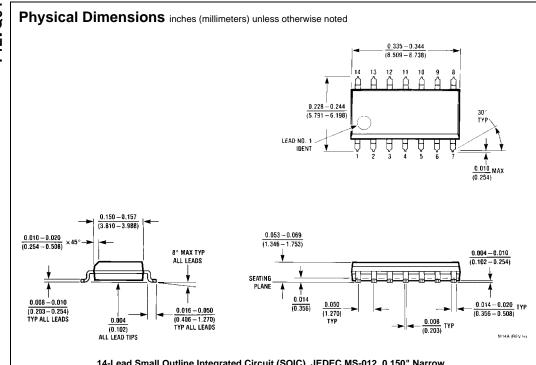
	Parameter	V _{CC} (V)	$T_A = +25$ °C $C_L = 50 \text{ pF}$			$T_A = -40^{\circ} \text{ C to } +85^{\circ} \text{C}$		Units
Symbol						$C_L = 50 \text{ pF}$		
		(-)	Min	Тур	Max	Min	Max	•
t _{PLH}	Propagation Delay	2.7	1.5	5.4	12.7	1.0	14.0	2
		3.3 ± 0.3	1.5	4.5	9.0	1.0	10.0	ns
t _{PHL}	Propagation Delay	2.7	1.5	5.4	12.0	1.0	12.0	ns
		3.3 ± 0.3	1.5	4.5	8.5	1.0	9.5	115
t _{OSHL}	Output to Output Skew (Note 9)	2.7		1.0	1.5		1.5	20
t _{OSLH}	Data to Output	3.3 ± 0.3		1.0	1.5		1.5	ns

Note 9: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}). Parameter guaranteed by design.

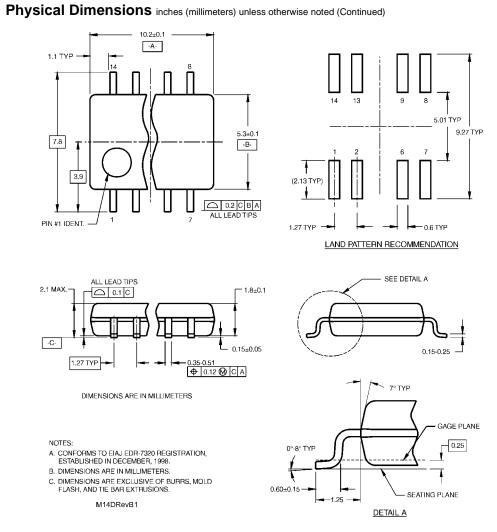
Capacitance

Symbol Parameter		Тур	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = Open
C _{PD} (Note 10)	Power Dissipation Capacitance	17	pF	V _{CC} = 3.3V

Note 10: C_{PD} is measured at 10 MHz.



14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M14A



14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M14D

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

www.fairchildsemi.com

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hol

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81–3–5817–1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative